

<b>Notice of References Cited</b>			Application/Control No. 10/776,433	Applicant(s)/Patent Under Reexamination REN ET AL.	
			Examiner Patricia Leith	Art Unit 1655	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,192,817	03-1993	Takaishi et al.	549/298
*	C	US-5,430,054	07-1995	Qian et al.	514/468
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	L	US-	.		
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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